

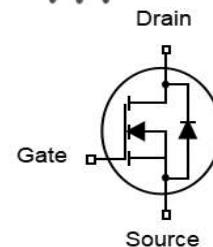


## Features

- N-Channel
- Excellent gate charge x  $R_{DS(on)}$  product
- Very low on-resistance  $R_{DS(on)}$
- 150 °C operating temperature
- Pb-free lead plating
- 100% EAS tested

$V_{DS}$	60	V
$R_{DS(on),TYP}@ V_{GS}=10\text{ V}$	2.7	$\text{m}\Omega$
$I_D$	160	A

TO-220



Part ID	Package Type	Marking	Packing
ZTG020N06	TO-220	ZTG020N06	1000pcs/Tape

## Absolute Maximum Ratings $T_A=25^\circ\text{C}$ , unless otherwise specified

Symbol	Parameter	Rating	Unit	
<b>Common Ratings (Tc=25°C Unless Otherwise Noted)</b>				
$V_{GS}$	Gate-Source Voltage	$\pm 20$	V	
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	60	V	
$T_J$	Maximum Junction Temperature	150	°C	
$T_{STG}$	Storage Temperature Range	-55 to 150	°C	
$I_{DM}$	Drain Current-Continuous@ Current-Pulsed	$T_c=25^\circ\text{C}$	640	A
<b>Mounted on Large Heat Sink</b>				
$I_D$	Drain Current-Continuous	$T_c=25^\circ\text{C}$	160	A
		$T_c=100^\circ\text{C}$	102	A
$P_D$	Maximum Power Dissipation	125	W	
$dv/dt$	Drain Source voltage slope, $V_{DS} \leq 48\text{V}$	50	V/ns	
$dv/dt$	Reverse diode $dv/dt$ , $V_{DS} \leq 48\text{V}$ , $I_{SD} < I_D$	15	V/ns	
$R_{\theta JC}$	Thermal Resistance-Junction to Case (Note 2)	1.0	°C/W	
<b>Drain-Source Avalanche Ratings</b>				
EAS	Avalanche Energy, Single Pulsed (Note 5)	232	mJ	



**Electrical Characteristics ( $T_j=25^\circ\text{C}$  unless otherwise noted)**

Symbol	Parameter	Condition	Min	Typ	Max	Unit
<b>Static Electrical Characteristics @ <math>T_j=25^\circ\text{C}</math> (unless otherwise stated)</b>						
V(BR)DSS	Drain-Source Breakdown Voltage	$V_{GS}=0\text{V}, I_D=250\mu\text{A}$	60	--	--	V
Idss	Zero Gate Voltage Drain Current	$V_{DS}=60\text{V}, V_{GS}=0\text{V}$	--	--	1	$\mu\text{A}$
IGSS	Gate-Body Leakage Current	$V_{GS}=\pm 20\text{V}, V_{DS}=0\text{V}$	--	--	$\pm 100$	nA
VGS(th)	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	2.3	3.0	3.7	V
RDS(on)	Drain-Source On-State Resistance <sup>(Note 3)</sup>	$V_{GS}=10\text{V}, I_D=50\text{A}$	--	2.7	3.2	$\text{m}\Omega$

**Dynamic Electrical Characteristics @  $T_j = 25^\circ\text{C}$  (unless otherwise stated)** <sup>(Note 4)</sup>

Ciss	Input Capacitance	$V_{DS}=30\text{V}, V_{GS}=0\text{V}, f=1\text{MHz}$	--	4100	--	pF
Coss	Output Capacitance		--	1010	--	pF
Crss	Reverse Transfer Capacitance		--	36	--	pF
Rg	Gate Resistance	f=1MHz	--	3.4	--	$\Omega$
Qg	Total Gate Charge	$V_{DS}=30\text{V}, I_D=80\text{A}, V_{GS}=10\text{V}$	--	62	--	nC
Qgs	Gate-Source Charge		--	25	--	nC
Qgd	Gate-Drain Charge		--	14	--	nC

**Switching Characteristics** <sup>(Note 4)</sup>

Td(on)	Turn-on Delay Time	$V_{DD}=30\text{V}, I_D=80\text{A}, R_G=3.0\Omega, V_{GS}=10\text{V}$	--	22	--	ns
Tr	Turn-on Rise Time		--	31	--	ns
Td(off)	Turn-Off Delay Time		--	47	--	ns
Tf	Turn-Off Fall Time		--	19	--	ns

**Source-Drain Diode Characteristics@  $T_j = 25^\circ\text{C}$  (unless otherwise stated)**

Is	Diode Forward Current <sup>(Note 2)</sup>		--	--	160	A
VSD	Forward on voltage <sup>(Note 3)</sup>	$I_S=80\text{A}, V_{GS}=0\text{V}$	--	--	1.4	V
Tr	Reverse Recovery Time	$V_{DD}=30\text{V}, I_F=80\text{A}$ $di/dt=100\text{A}/\mu\text{s}$	--	50	--	ns
Qrr	Reverse Recovery Charge		--	66	--	nC

**Notes:**

1. Repetitive Rating: Pulse width limited by maximum junction temperature.
2. Surface Mounted on FR4 Board,  $t \leq 10$  sec.
3. Pulse Test: Pulse Width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 2\%$ .
4. Guaranteed by design, not subject to production
5. EAS condition :  $T_j=25^\circ\text{C}, V_{DD}=50\text{V}, V_G=10\text{V}, L=0.1\text{mH}, R_g=25\Omega$



### Typical Electrical and Thermal Characteristics

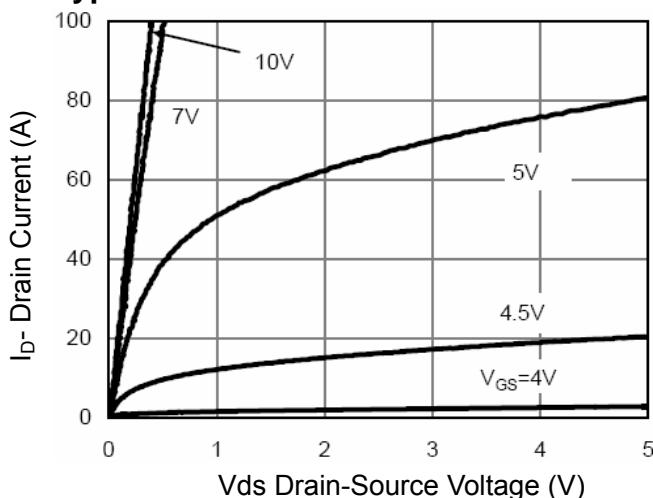


Figure 1 Output Characteristics

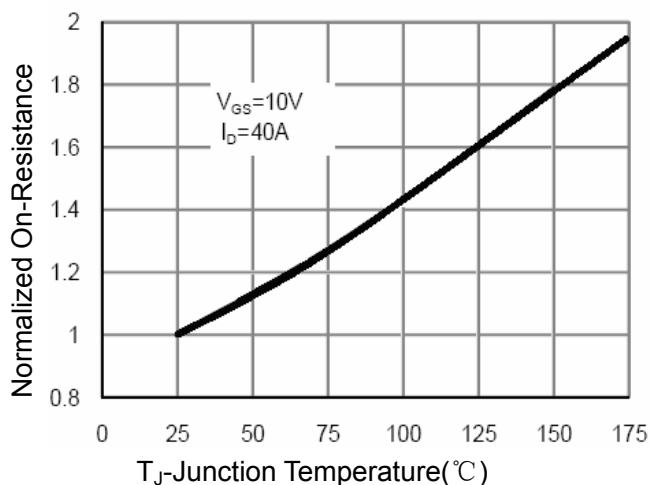


Figure 4 Rdson-Junction Temperature

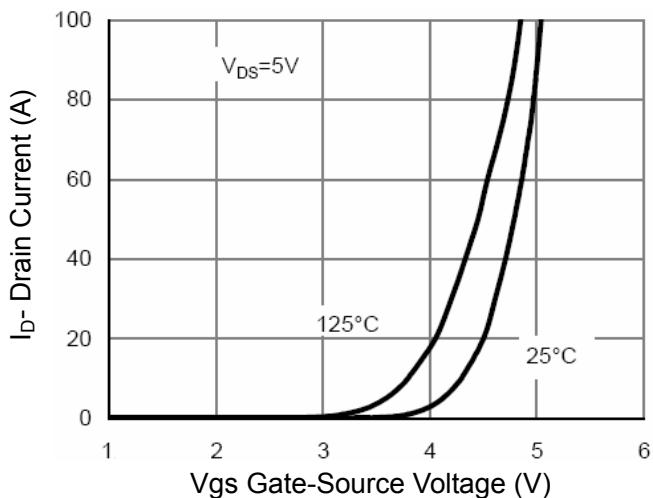


Figure 2 Transfer Characteristics

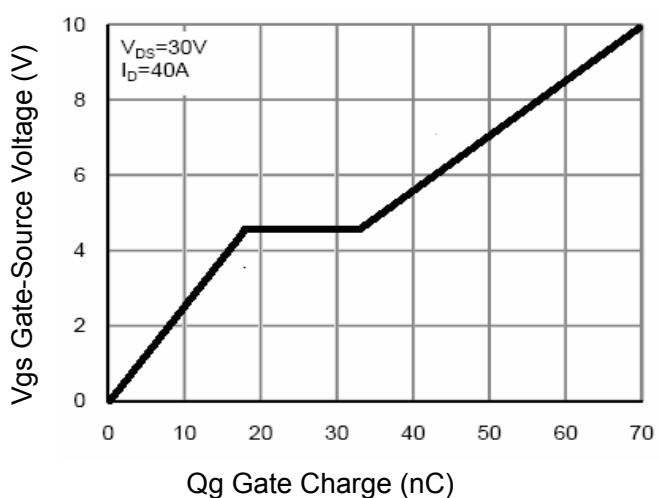


Figure 5 Gate Charge

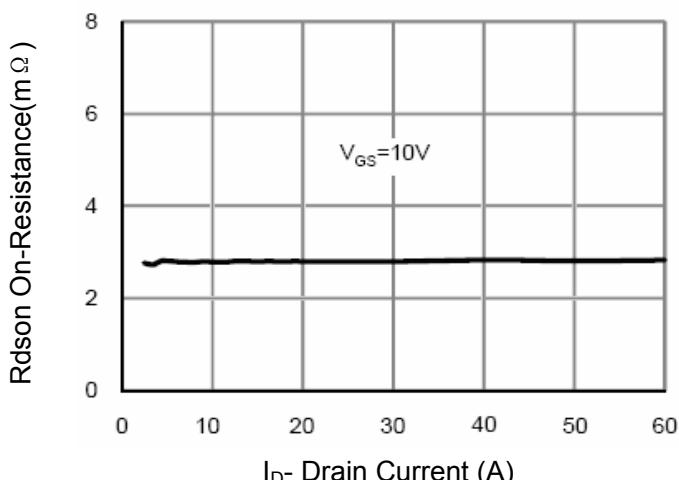


Figure 3 Rdson- Drain Current

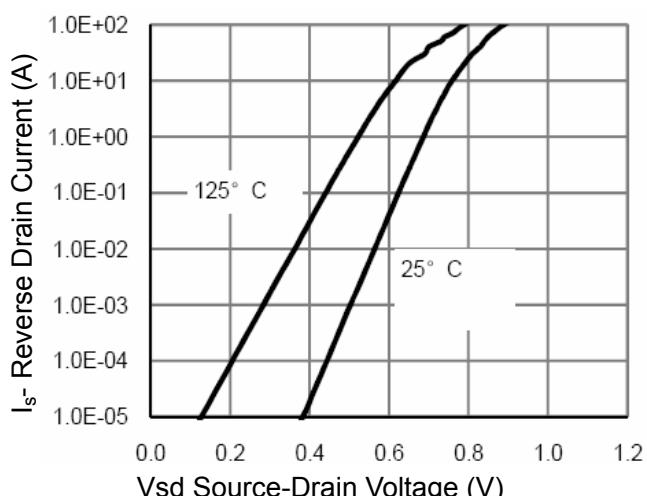
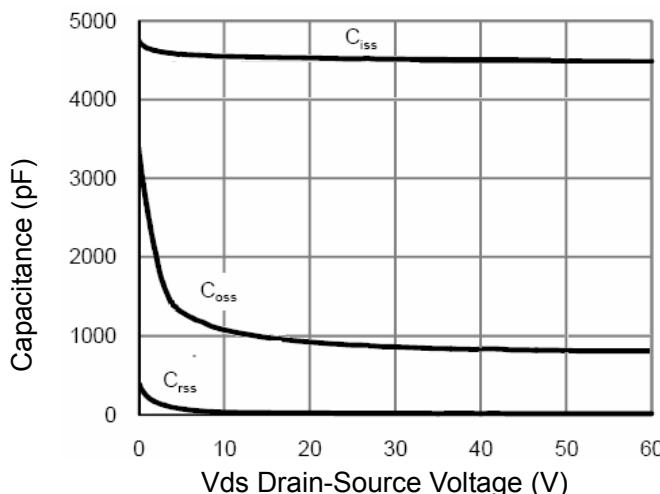
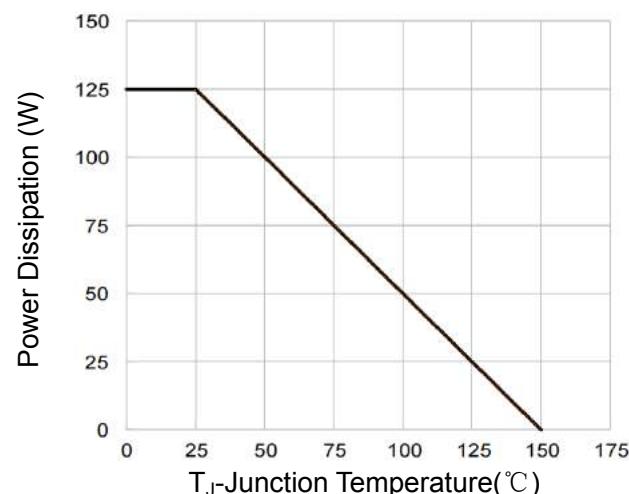


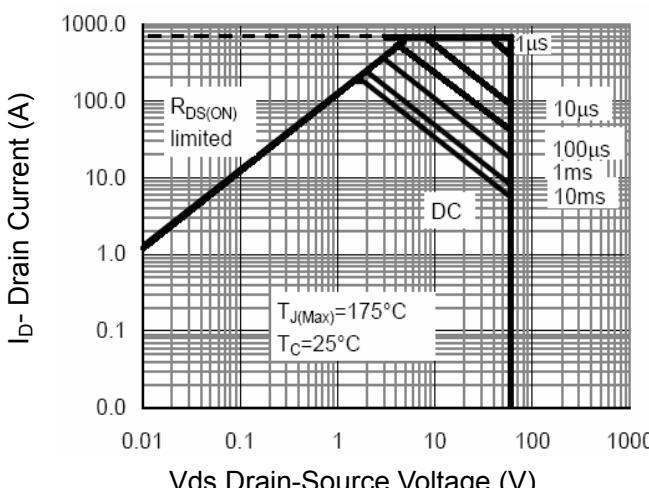
Figure 6 Source- Drain Diode Forward



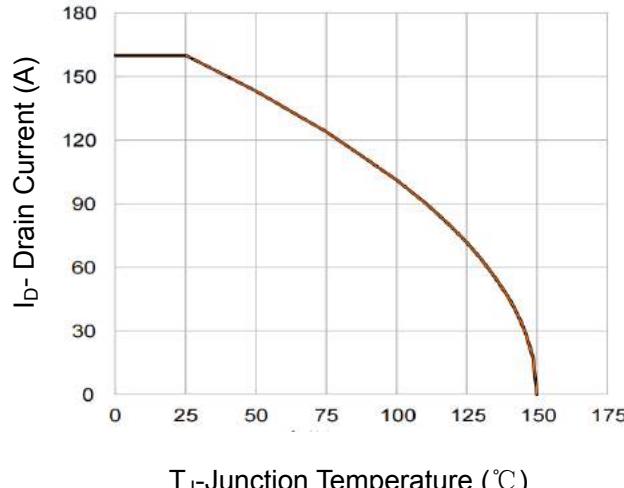
**Figure 7 Capacitance vs Vds**



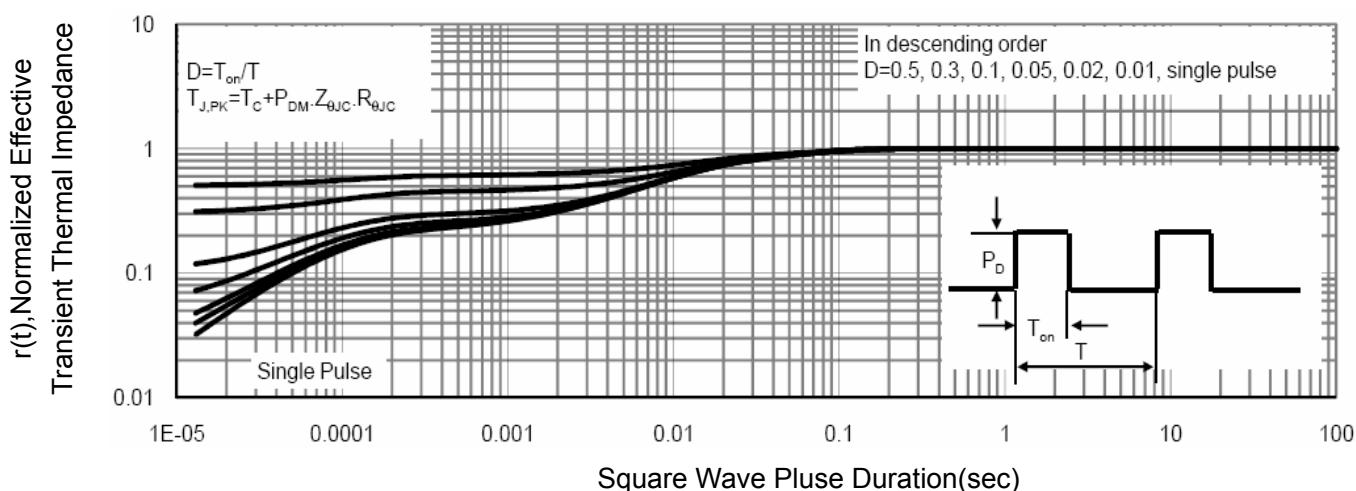
**Figure 9 Power De-rating**



**Figure 8 Safe Operation Area**



**Figure 10 Current De-rating**

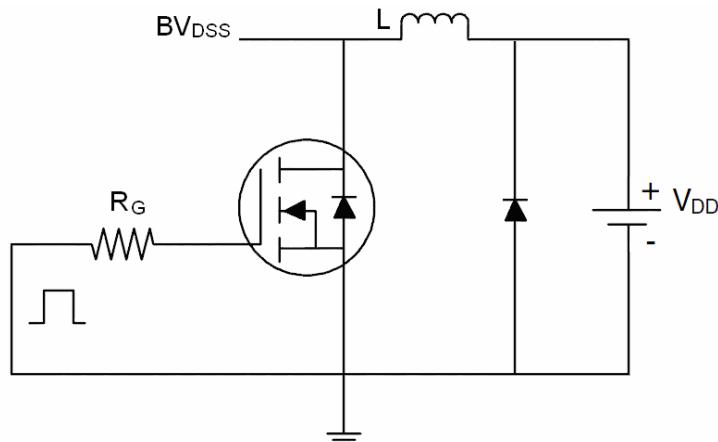


**Figure 11 Normalized Maximum Transient Thermal Impedance**

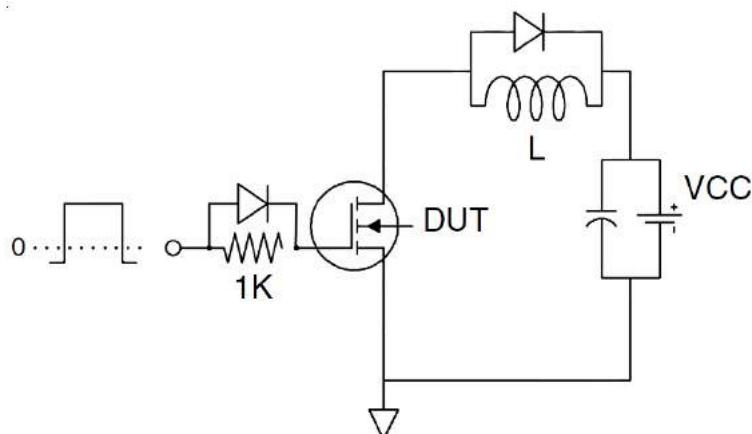


## Test Circuit

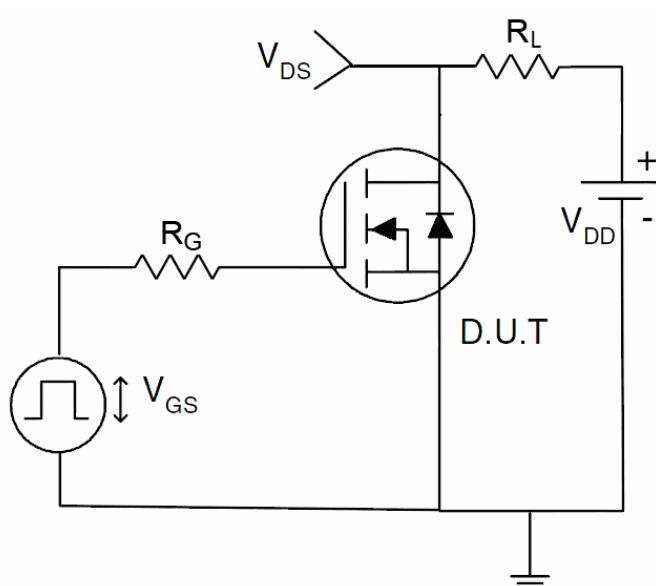
### 1) E<sub>AS</sub> test Circuit



### 2) Gate charge test Circuit

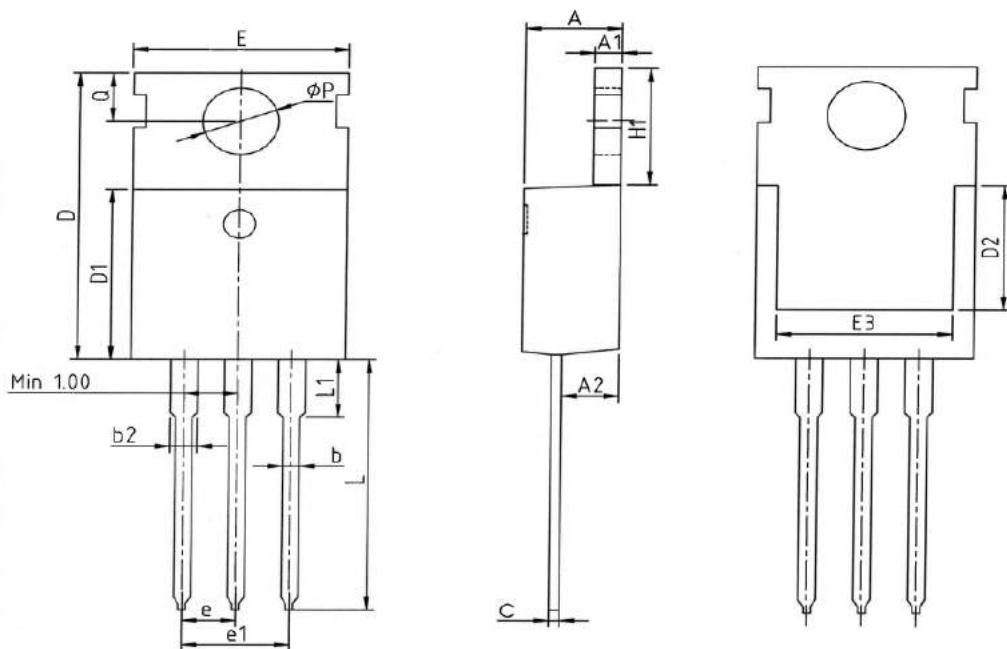


### 3) Switch Time Test Circuit





## TO-220-3L Package Information



SYMBOL	MIN	NOM	MAX
A	4.37	4.57	4.70
A1	1.25	1.30	1.40
A2	2.20	2.40	2.60
b	0.70	0.80	0.95
b2	1.17	1.27	1.47
c	0.45	0.50	0.60
D	15.10	15.60	16.10
D1	8.80	9.10	9.40
D2	5.50	6.30	7.10
E	9.70	10.00	10.30
E3	7.00	7.80	8.60
e		2.54	BSC
e1		5.08	BSC
H1	6.25	6.50	6.85
L	12.75	13.50	13.80
L1	-	3.10	3.40
ΦP	3.40	3.60	3.80
Q	2.60	2.80	3.00

## Customer Service

### Sales and Service:

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